

## Special Issue

# Delft Workshop 2008-2009— Sensors and Imagers: a VLSI Perspective

### Message from the Guest Editor

#### Symposium:

Sensors and Sensor Networks: A VLSI Design  
Perspective

1 December 2008 - TU Delft

Fac. AE (L&R)

Collegezaal C

Kluyverweg 1

Delft, The Netherlands

<http://cas.et.tudelft.nl/>

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### Guest Editor

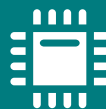
Prof. Dr. Edoardo Charbon

Chair of VLSI Design, Department of Microelectronics, Delft University  
of Technology, Delft, Netherlands

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### Deadline for manuscript submissions

closed (28 February 2010)



## Sensors

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### Editor-in-Chief

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